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## Quasiparticle-Injection-Induced Superconducting Weak Links\*

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Superconducting weak links are studied in which the weak region is created by locally driving the superconductor out of equilibrium using an independent source of quasiparticles. The characteristics of these weak links can be varied electrically or optically at any temperature below  $T_c$ . A simple model which describes the dependence of weak-link critical current on quasiparticle-injection rate is presented.

A common feature of all superconducting weak links is a localized region of depressed superconducting order parameter separating two superconductors. The size of the localized weak region must be comparable with or smaller than a characteristic length of the superconductor, generally supposed to be the temperature-dependent coherence length  $\xi(T)$ . This condition imposes rather severe constraints on the fabrication and operation of weak links. The link dimensions must be at the micrometer level and desired operating characteristics can often be achieved only within a rather restricted temperature interval. We report here some initial experimental observations on a new class of weak links in which the weak region is not a result of a fabrication process, but is created by locally driving the superconductor out of equilibrium using a source of quasiparticles which is independent of the primary weaklink circuit.<sup>1</sup> The characteristics of these weak links can be electrically or optically varied at any temperature below  $T_c$ . We also present a simple model, based on current understanding of the nonequilibrium superconductor, which accounts for

the dependence of the weak-link critical current on quasiparticle-injection rate.

Consider a narrow thin-film strip of superconductor, a microbridge of width W. Suppose it is possible by some means to inject or create excess quasiparticles over a length L of the microbridge. The resulting excess quasiparticle density will be position dependent, varying slowly within L and falling to zero outside L in a distance of the order of the guasiparticle diffusion length  $\lambda$ =  $(v_{\rm qp} l \tau_{\rm eff}/3)^{1/2}$ . Here  $v_{\rm qp}$  is an average quasiparticle velocity approximately equal to the Fermi velocity, l is the quasiparticle elastic scattering mean free path, and  $\tau_{eff}$  is a characteristic quasiparticle relaxation time, probably the effective quasiparticle-recombination time. The excess quasiparticles will depress the superconducting order parameter over some distance  $\Lambda \sim L + 2\lambda$ , creating a weak link if  $\Lambda$  is sufficiently small and the depression sufficiently strong. The characteristics of this weak link, e.g., the critical current, depend basically on  $\Lambda$  and on  $\Delta_{\min}$ , the gap parameter at its minimum within L. These parameters in turn depend in a rather complicated

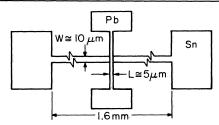


FIG. 1. Quasiparticle-injection weak-link configuration (not to scale).

way on the rate of injection or creation of quasiparticles.

We have most extensively studied quasiparticleinjection weak links in the configuration shown in Fig. 1. It shows a thin-film Sn microbridge about 1.6 mm long, 10  $\mu$ m wide, and 600 to 1000 Å thick, crossed by a Pb strip about 5  $\mu$ m wide which is separated from the microbridge by a tunnel barrier formed by thermal oxidation or by glow-discharge oxidation. The critical-current densities of our tunnel junctions ranged from  $\sim 10$ to ~400 A cm<sup>-2</sup>. Pb was used for the tunnel-injection electrode to ensure that it remained superconducting over the required range of injection currents. The injection current was divided equally between the two halves of the microbridge to ensure a symmetric distribution of guasiparticles in the injection region and to eliminate any injection-current contribution to the measured current-voltage (I-V) characteristics of the microbridge. Four-terminal measurements of both the injection tunnel junction and microbridge I-Vcharacteristics were made over the bath-temperature range 1.3 to 4.2 K. The background ambient magnetic field was less than 1 mG.

Figure 2 shows the variation with injection current  $I_J$  of the *I-V* characteristic of such a tunnelinjection weak link at low reduced temperature. For  $I_{J} = 0$ , the critical current  $I_{c}$  is large (23 mA) and the *I-V* characteristic is strongly hysteretic. This behavior is typical of that attributed to the formation of a "hot spot" by Skocpol, Beasley, and Tinkham.<sup>2</sup> Very little change occurs for  $I_J$  $\lesssim 500 \ \mu$ A. With further increase in  $I_{J}$ ,  $I_c$  begins to decrease, but the hot-spot behavior presists down to critical currents of several milliamperes. Then the *I*-*V* characteristic begins to change toward the nonhysteretic shape generally associated with "ideal" weak links. Finally,  $I_c$  decreases to zero at  $I_J = I_{J_0} = 1.232$  mA. With further increase in  $I_{J}$ , the resistance of the now-normal link increases nonlinearly.

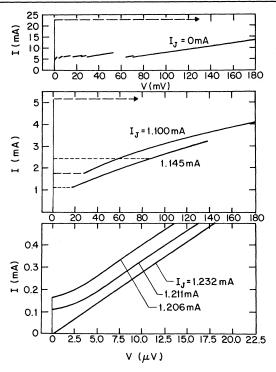


FIG. 2. Variation of weak-link I-V characteristic with tunnel-injection current.  $W=10 \mu m$ ;  $L=6 \mu m$ ; T=2.07 K. Note changes in current and voltage scales.

Some other general features of the behavior of these tunnel-injection weak links are the following: (1) For  $I_c \lesssim 25 \ \mu A$ , the critical current becomes very sensitive to an applied magnetic field. A field of about 1 G perpendicular to the film plane drives the critical current to zero. (2) For  $T \leq T_{\lambda}$  and for fixed L, the injector power required to drive  $I_c$  to zero remains approximately constant as the normal-state resistance  $R_N$  of the injector junction is varied. For T = 2 K, and L = 5  $\mu$ m,  $I_{J_0}^2 R_N \simeq 8 \mu$ W. The corresponding bias voltage on the injector junction ranged from about  $3(\Delta_{\rm Sn} + \Delta_{\rm Pb})/e$  for  $R_{\rm N} = 5 \Omega$  to  $22(\Delta_{\rm Sn} + \Delta_{\rm Pb})/e$  for  $R_{\rm N} = 240 \ \Omega$ . (3)  $I_{J_0}$  increases continuously with decreasing temperature down to  $T = T_{\lambda}$ , where it jumps sharply by about 20% and then continues to increase. There is a corresponding sharp drop in the weak-link resistance at  $I_{J_0}$  at  $T = T_{\lambda}$ . Both effects reflect the sudden improvement in phonon removal from the weak link as T is decreased below  $T_{\lambda}$ . (4) The differential resistance of the weak link at high bias voltage decreases slowly with increasing  $I_J$  up to  $I_{J_0}$ . This appears to correspond to a shrinking of the weak region. (5) The canonical test for the presence of Josephson phase coupling in a weak link is the appearance

of steps in the *I-V* characteristic in the presence of rf radiation. For  $I_J = 0$ , we were unable to observe any such steps at *X*-band frequencies at any temperature significantly below  $T_c$ . With  $I_c$  tuned into the range 200  $\mu A \leq I_c \leq 3$  mA we were able to observe rf-induced steps up to n = 3 at all temperatures with moderate microwave powers. The maximum observed amplitude of the n = 1 step was about  $I_c/8$ . We also frequently observed the  $n = \frac{1}{2}$  and  $n = \frac{3}{2}$  subharmonic steps. No steps were observed in the region  $I_c \leq 200 \ \mu A$  where the *I-V* characteristic had the ideal-weak-link shape.

We have had several unintended opportunities to study another variant of the quasiparticle-injection weak link, one we call the "point-injection" weak link. These resulted from accidental shorting of the tunnel barrier. If such an event is not catastrophic, there is evidence<sup>3</sup> that it often results in a single metallic conducting path through the oxide barrier only a few hundred angstroms in diameter. The injection area is then much smaller than for an undamaged barrier. The behavior of these point-injection weak links is generally similar to that of the tunnel-injection weak link.  $I_{J_0}$  is larger but the injector power at  $I_{J_0}$  is still ~ 8  $\mu$ W. The weak-region size  $\Lambda$ appears to be significantly smaller. The rf-induced steps are considerably larger (maximum n = 1 step amplitude ~ $I_c/3$ ) and steps can be observed for 3 mA  $\geq I_c \geq 0$ .

The basic ingredients of a model which may be used in discussion of these experimental results are (1) a connection between  $I_J$  and the excessquasiparticle distribution in the injection region, and (2) a connection between this distribution and the superconducting gap parameter or order parameter. For the first we use the phenomenological Rothwarf-Taylor equations,<sup>4</sup> extended to include quasiparticle and phonon diffusion along the microbridge. The steady-state quasiparticle equation may be written as

$$D\frac{\partial^2 N}{\partial x^2} + I_0(x) - \frac{R(N^2 - N_T^2)}{(1 + \tau_\gamma / \tau_B)} = 0.$$
 (1)

The diffusion constant  $D = v_{\rm qp}l/3$ ,  $I_0(x)$  is the injection rate density, N is the quasiparticle number density,  $N_T$  is the thermal-equilibrium quasiparticle number density, R is the intrinsic singlequasiparticle recombination rate constant, and  $(1 + \tau_{\gamma}/\tau_B)$  is the so-called phonon-trapping factor. Because the phonon mean free path against pair breaking is very short, it can be argued that phonon diffusion is unimportant, so that the Rothwarf-Taylor phonon equation is unmodified.

Details of the solutions of these equations will be reported elsewhere; they include the following qualitative features. Because the recombination rate for a given quasiparticle is proportional to the quasiparticle density, when the injection rate is sufficiently high that  $N > N_T$  (a regime commonly called overinjected),  $au_{\rm eff}$  becomes less than the near-equilibrium phonon-trapped recombination time and the quasiparticle diffusion length  $\lambda$ decreases. This accounts for the observed decrease in effective link length with increasing  $I_{J}$ . For the point-injection weak links, L may be only several hundred angstroms, and  $\lambda \ge L$ . In this case,  $\Lambda$  should be strongly dependent on injection level, an expectation in accord with our observations.

For comparison with the tunnel-injection weaklink data reported here, we have used a simplified version of the above, in which the diffusion term is crudely approximated by  $-\alpha I_0$ , where  $\alpha$ is the fraction of injected quasiparticles lost from the injection area by diffusion. Then Eq. (1) becomes simply

$$N = [I_0(1 - \alpha)R^{-1}(1 + \tau_{\gamma}/\tau_B) + N_T^2]^{1/2}.$$
 (2)

For the second basic ingredient in our model we use Parker's modified heating or  $T^*$  model.<sup>5</sup> In the  $T^*$  model it is assumed that the nonequilibrium excess quasiparticles and the phonons with energies greater than  $2\Delta$  (those emitted in guasiparticle-recombination events or absorbed in phonon pair-breaking events) are in steady-state quasithermal distributions characterized by a temperature  $T^*$ , while phonons with energies less than  $2\Delta$  are at temperature T, the ambient or bath temperature. (This overall nonthermal phonon distribution distinguishes this model from a simple heating model in which all phonons are characterized by the same temperature. The  $T^*$ model fits existing nonequilibrium-superconductor experiments rather well, while the simple heating model does not.<sup>5</sup>) We identify the gap parameter yielded by the  $T^*$  model for given N with  $\Delta_{\min}$ . (We note, however, that the  $T^*$  model assumes a spatially homogeneous system. If  $\Lambda$  is comparable with  $\xi$ , as it probably is in our weak links, we can have no confidence that the model is applicable, but we use it anyway for want of anything better.)

We also need a relation between  $I_0$  and  $I_J$ . We assume that quasiparticle injection at voltage  $V_J$  $\simeq I_J R_N \gg (\Delta_{Sn} + \Delta_{Pb})/e$  leads to a steady-state quasiparticle distribution at temperature  $T^*$  in

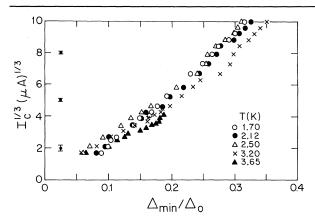


FIG. 3. Gap dependence of weak-link critical current for different bath temperatures. The error bars are typical for the indicated regions of  $I_c$ <sup>1/3</sup>.

which the average quasiparticle energy is approximately  $\Delta_0$ , the zero-temperature zero-injection gap.<sup>5</sup> Half the injector power goes to the excess quasiparticles and phonons on one side of the injector junction, with a fraction<sup>5, 6</sup> F appearing in the quasiparticles. With these assumptions

$$I_0 \simeq \frac{1}{2} F I_J^2 R_N / \Delta_0 W L d, \qquad (3)$$

where d is the film thickness.

A detailed comparison of this model with our experimental data is beyond the scope of this Letter and will be reported elsewhere. We present here just one pertinent result. The temperature or gap dependence of the critical current of weak links near  $T_c$  has been investigated by many workers.<sup>1, 7-9</sup> The most popular result is  $I_c \propto (1-t)^{3/2}$ which, using the BCS relation  $\Delta \propto (1-t)^{1/2}$ , corresponds to  $I_c \propto \Delta^3$ . Figure 3 shows, for a variety of bath temperatures, our observed  $I_c^{1/3}$  versus  $\Delta_{\min}$ , where we have translated the experimentally observed parameter  $I_J$  into  $\Delta_{\min}$  using the simplified model outlined above. The dependence of  $I_c$  on  $\Delta_{\min}$  is close to  $\Delta_{\min}^3$  for  $\Delta_{\min} \leq 0.2\Delta_0$ . In the course of the translation, we obtained a nearequilibrium phonon-trapped quasiparticle recombination time for Sn in excellent agreement with other experiments.<sup>10,11</sup>

Although we have emphasized here the quasiparticle-injection weak link, the general ideas underlying its operation apply also to weak links in which the quasiparticles are created by other methods. We have made some very preliminary experiments on both photon- and phonon-induced weak links. In the latter case, the phonons were generated by a narrow (~ 1  $\mu$ m) normal-metal heater strip crossing a Sn variable-thickness bridge<sup>12</sup> (a short microbridge which is substantially thinner than the superconducting films it connects). The heater was isolated from the bridge by a thick (~ 1  $\mu$ m) insulating film of SiO to prevent tunneling. The phonons create quasiparticles in the microbridge by pair breaking. A tunable critical current and rf-induced steps were again observed.

Our photoinjection weak link consisted of a Sn variable-thickness bridge 1000 Å thick by ~0.5  $\mu$ m long by 10  $\mu$ m wide, with all but the bridge region screened by an opaque silver film. The critical current of the bridge was varied using light from an ordinary high-intensity reading-lamp bulb. The rf-induced-step test in this case yielded rather spectacular results: In the absence of light, no steps could be seen. Under certain circumstances (not yet well defined, but apparently associated with minimal substrate heating) more than 50 steps extending beyond a bias voltage of 1 mV appeared.

We anticipate that further study of the several types of quasiparticle-injection-induced superconducting weak links we have described here will contribute to better understanding of both nonequilibrium phenomena in superconductors and the basic mechanisms of weak-link behavior. Their controllability may also have practical benefits.

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